

2NN60-CBS Preliminary Power MOSFET

DUAL N-CHANNEL ENHANCEMENT MODE

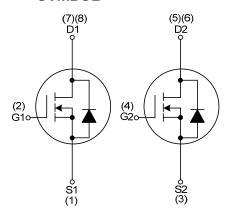
DESCRIPTION

The UTC **2NN60-CBS** is a high voltage power MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

■ FEATURES

- * $R_{DS(ON)}$ < 8.50 @ V_{GS} = 10V, I_{D} =1.0A
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness

■ SYMBOL



■ ORDERING INFORMATION

	Ordering Number		Dookogo	Pin Assignment							Dooking	
	Lead Free	Halogen Free	Package	1	2	3	4	5	6	7	8	Packing
	2NN60L-K08-5060-R	2NN60G-K08-5060-R	DFN5060-8	S1	G1	S2	G2	D2	D2	D1	D1	Tape Reel
Note: Pin Assignment: G: Gate D: Drain S: Source								_				

2NN60G-K08-5060-R

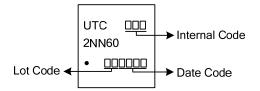
(1) Packing Type
(2) R: Tape Reel
(2) K08-5060: DFN5060-8

(3) G: Halogen Free and Lead Free, L: Lead Free

1 transport | DFN5060-8

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■ MARKING



■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETE	SYMBOL	RATINGS	UNIT		
Drain-Source Voltage	V_{DSS}	600	V		
Gate-Source Voltage	V_{GSS}	±30	V		
Continuous Drain Current	Continuous	I_{D}	2.0	Α	
Pulsed Drain Current Pulsed (Note 2)		I_{DM}	8.0	Α	
Avalanche Current (Note 3)	I_{AR}	1.5	Α		
Avalanche energy	E_{AS}	11	mJ		
Peak Diode Recovery dv/dt (Note 4	dv/dt	4.0	V/nS		
Power Dissipation	P_{D}	22	W		
Junction Temperature	TJ	+150	°C		
Storage Temperature Range	T_{STG}	-55 ~ +150	°C		

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L=10mH, I_{AS} =1.5A, V_{DD} =50V, R_{G} =25 Ω , Starting T_{J} = 25 $^{\circ}$ C.
- 4. $I_{SD} \le 2.0 A$, $di/dt \le 100 A/\mu s$, $V_{DD} \le V_{(BR)DSS}$, $T_J = 25 ^{\circ} C$.

■ THERMAL CHARACTERISTICS

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	75	°C/W	
Junction to Case	θ_{JC}	5.7	°C/W	

■ **ELECTRICAL CHARACTERISTICS** (T_J =25°C, unless otherwise specified)

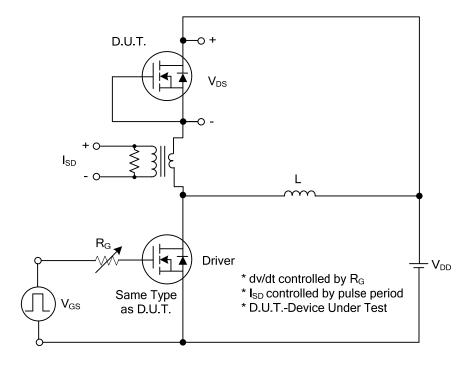
PARAMETER	SYMBOL	TEST CONDITIONS MIN TYP MAX							
OFF CHARACTERISTICS									
Drain-Source Breakdown Voltage		BV_{DSS}	$V_{GS} = 0V, I_{D} = 250\mu A$	600			V		
Drain-Source Leakage Current	_	I _{DSS}	$V_{DS} = 600V, V_{GS} = 0V$			1	μΑ		
Gate-Source Leakage Current	Forward	I _{GSS}	$V_{GS} = 30V, V_{DS} = 0V$			100	nA		
Gate-Source Leakage Current	Reverse		$V_{GS} = -30V, V_{DS} = 0V$			-100	nA		
ON CHARACTERISTICS									
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V			
Static Drain-Source On-State Res	istance	R _{DS(ON)}	$V_{GS} = 10V, I_{D} = 1.0A$			8.5	Ω		
DYNAMIC CHARACTERISTICS									
Input Capacitance		C _{ISS}			177		pF		
Output Capacitance		Coss	$V_{GS} = 0V, V_{DS} = 25V, f = 1MHz$		26		pF		
Reverse Transfer Capacitance		C_{RSS}			7.4		pF		
SWITCHING CHARACTERISTICS									
Total Gate Charge (Note 1)		Q_G	\/ -E0\/ \/ -10\/ -0.5A		15		nC		
Gate to Source Charge		Q_GS	V _{DS} =50V, V _{GS} =10V, I _D =0.5A, I _D =100μA (Note 1, 2)		1.7		nC		
Gate to Drain Charge		Q_GD	10-100μΑ (Note 1, 2)		1.7		nC		
Turn-on Delay Time (Note 1)		t _{D (ON)}			42		ns		
Rise Time		t_R	V_{DS} =30V, V_{GS} =10V, I_{D} =0.5A,		32		ns		
Turn-off Delay Time		$t_{D(OFF)}$	R _G =25Ω (Note 1, 2)		80		ns		
Fall-Time		t _F							
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS									
Maximum Body-Diode Continuous	Current	I_{SD}				2.0	Α		
Maximum Body-Diode Pulsed Cur	I _{SM}				8.0	Α			
Drain-Source Diode Forward Volta	V_{SD}	I _S =2.0A, V _{GS} =0V			1.4	V			
Reverse Recovery Time (Note 1)		t _{rr}	I _S =2.0A, V _{GS} =0V,		340		ns		
Reverse Recovery Charge		Q_{rr}	dI _F /dt=100A/µs		680		nC		

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%.

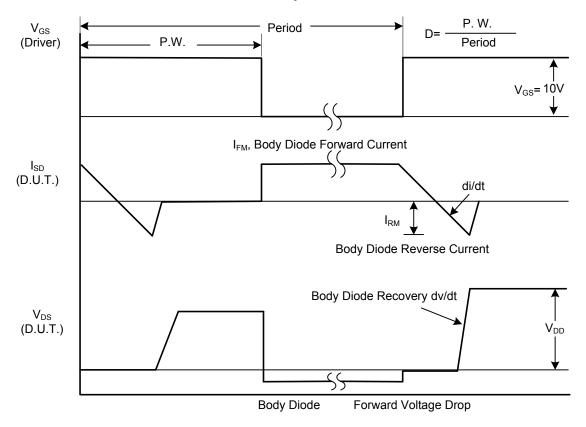
2. Essentially independent of operating temperature.



■ TEST CIRCUITS AND WAVEFORMS

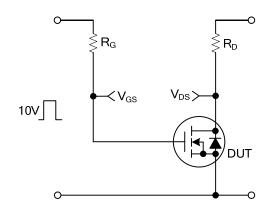


Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

■ TEST CIRCUITS AND WAVEFORMS (Cont.)



90%

10%

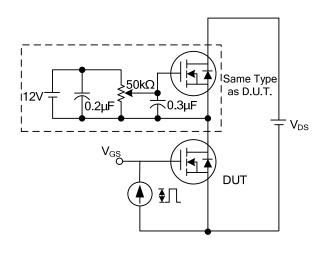
t_{d(ON)} t_R

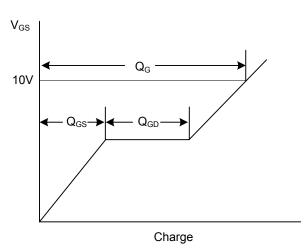
t_{OFF}

t_{OFF}

itching Test Circuit

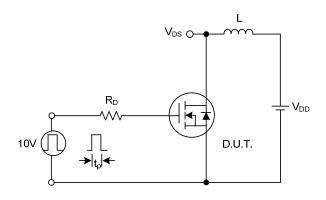
Switching Waveforms

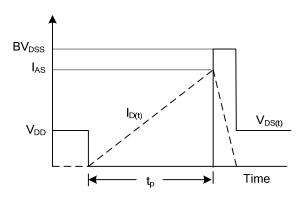




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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